IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

: Young-Geun PARK et al.

Appl. No.

: National Phase of PCT/KR04/00741

Filed

: Entry papers filed herewith: January 6, 2005

Title

: PROBE FOR A SCANNING PROBE MICROSCOPE

AND METHOD FOR FABRICATING SAME

Docket No.:

: PARK3031/REF

Customer No:

: 23364

PRELIMINARY AMENDMENT

MS PCT Office Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

The present application is the U.S. national phase of international application number PCT/KR04/00741.

Please amend the above-identified application as follows:

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 5 of this paper.